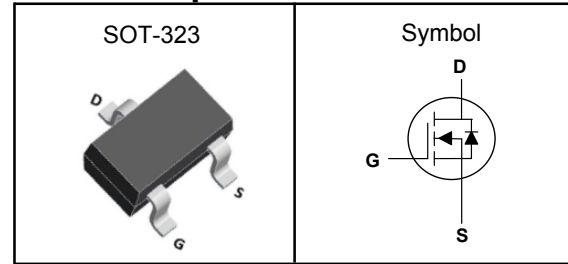


N-Channel Enhancement Mode MOSFET

Features

- Low R_{ds(on)} for low conduction loss
- Reliable and Rugged
- ROHS Compliant & Halogen-Free

Pin Description



Applications

- Power Management in Desktop Computer
- DC/DC Converters

V _{DSS}	30	V
R _{DS(ON)-Typ}	75	mΩ
I _D	2	A

Absolute Maximum Ratings (T_A=25°C, Unless Otherwise Noted)

Symbol	Parameter	Rating	Unit
V _{DSS}	Drain-Source Voltage	30	V
V _{GSS}	Gate-Source Voltage	±20	V
T _J	Maximum Junction Temperature	-55 to 150	°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
I _{DM} ^①	Pulse Drain Current Tested	8	A
I _D	Continuous Drain Current	T _C =25°C	2
	Continuous Drain Current	T _C =100°C	1.2
P _D	Maximum Power Dissipation	T _C =25°C	0.8
		0.8	W

Thermal Characteristics

Symbol	Parameter	Rating	Unit
R _{θJA}	Thermal Resistance-Junction to Ambient	415	°C/W

Note ① : Max. current is limited by bonding wire.

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C.

Note ③ : Surface Mounted on 1in² FR-4 board with 1oz.



N-Channel Enhancement Mode MOSFET

Electrical Characteristics ($T_J=25^{\circ}\text{C}$, Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
Static Electrical Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	30	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=30V, V_{GS}=0V$	---	---	1	μA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	---	2.5	V
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	---	---	± 100	nA
$R_{DS(on)}$	Drain-Source On-state Resistance	$V_{GS}=10V, I_D=2A$	---	75	90	m Ω
		$V_{DS}=4.5V, I_D=1A$	---	110	140	
gfs	Forward Transconductance	$V_{DS}=10V, I_D=2A$	---	1	---	S
Dynamic Characteristics ^⑤						
C_{iss}	Input Capacitance	$V_{GS}=0V, V_{DS}=25V, \text{Freq.}=1.0\text{MHz}$	---	55	---	pF
C_{oss}	Output Capacitance		---	20	---	
C_{rss}	Reverse Transfer Capacitance		---	8	---	
$T_{d(on)}$	Turn-on Delay Time	$V_{GS}=10V, V_{DD}=10V, I_D=22A, R_G=0.2\Omega$	---	4	---	nS
T_r	Turn-on Rise Time		---	30	---	
$T_{d(off)}$	Turn-off Delay Time		---	14	---	
T_f	Turn-off Fall Time		---	40	---	
Q_g	Total Gate Charge	$V_{GS}=10V, V_{DD}=10V, I_D=0.3A$	---	2	---	nC
Q_{gs}	Gate-Source Charge		---	0.6	---	
Q_{gd}	Gate-Drain Charge		---	1.2	---	
Source-Drain Characteristics						
V_{SD}	Diode Forward Voltage	$I_S=2A, V_{GS}=0V$	---	---	1.2	V

Note ④ : Pulse test (pulse width \leq 300us, duty cycle \leq 2%).

Note ⑤ : Guaranteed by design, not subject to production testing.

N-Channel Enhancement Mode MOSFET

Typical Characteristics

Figure 1. Output Characteristics

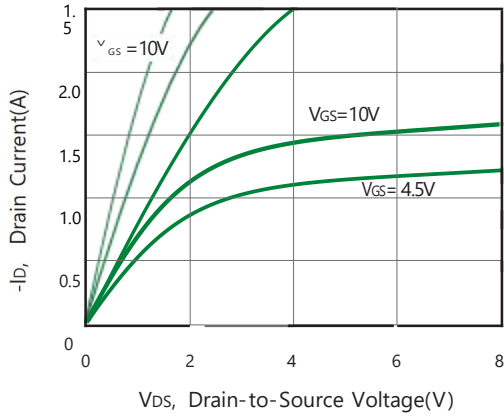


Figure 2. Body Diode Forward Voltage Variation with Source Current

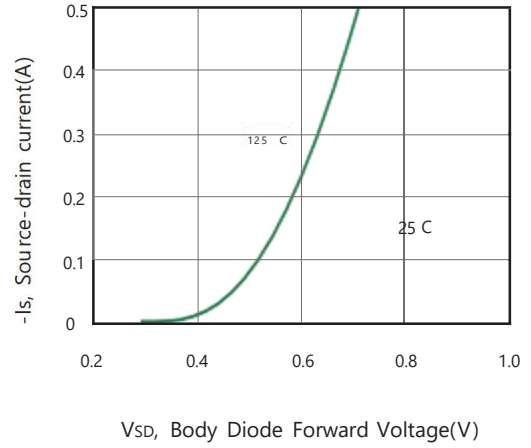


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

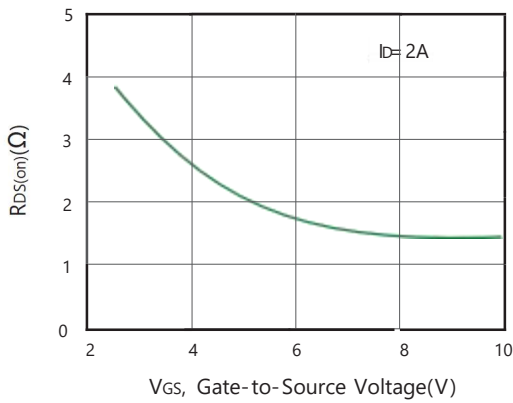


Figure 4. On-Resistance Variation with Drain Current and Temperature

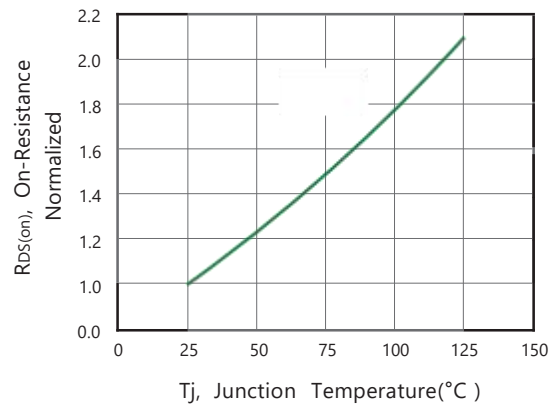


Figure 5. Gate Threshold Variation with Temperature

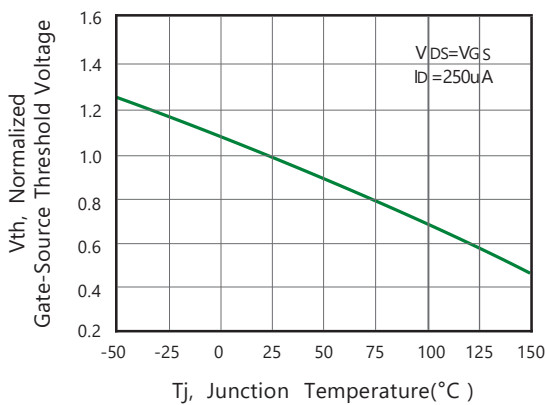
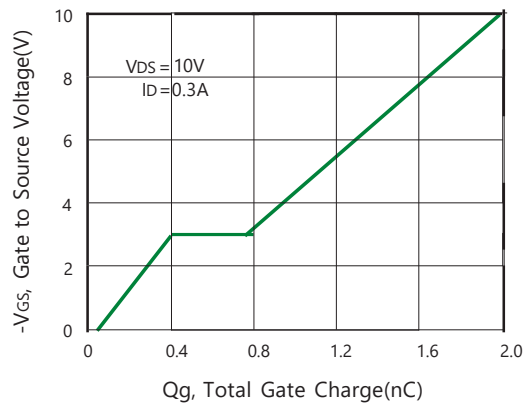


Figure 6. Gate Charge



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Figure 7. Capacitance

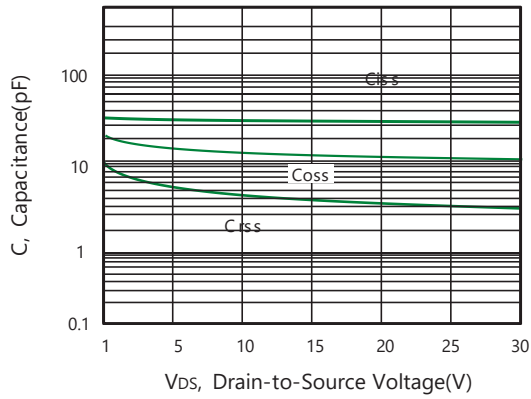


Figure 8. Maximum Safe Operating Area

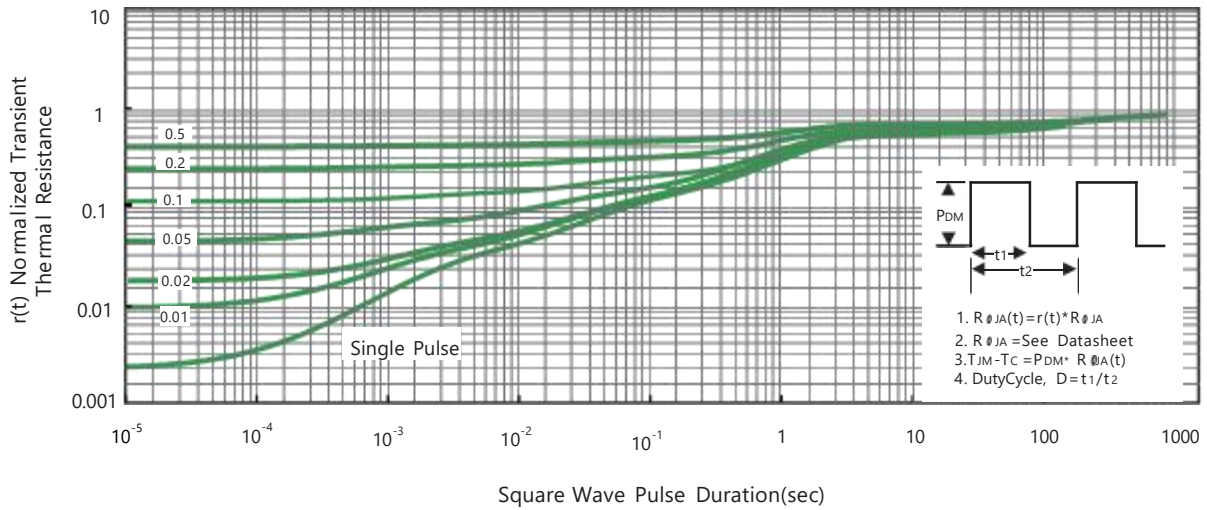
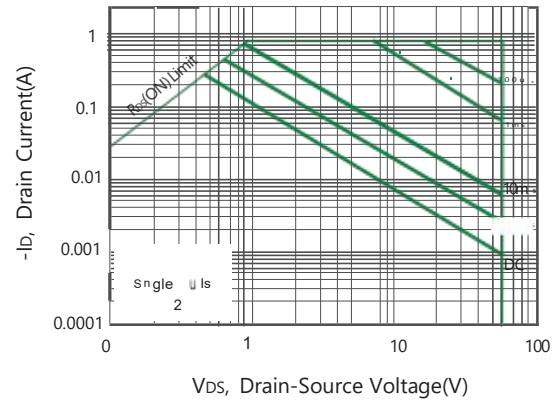
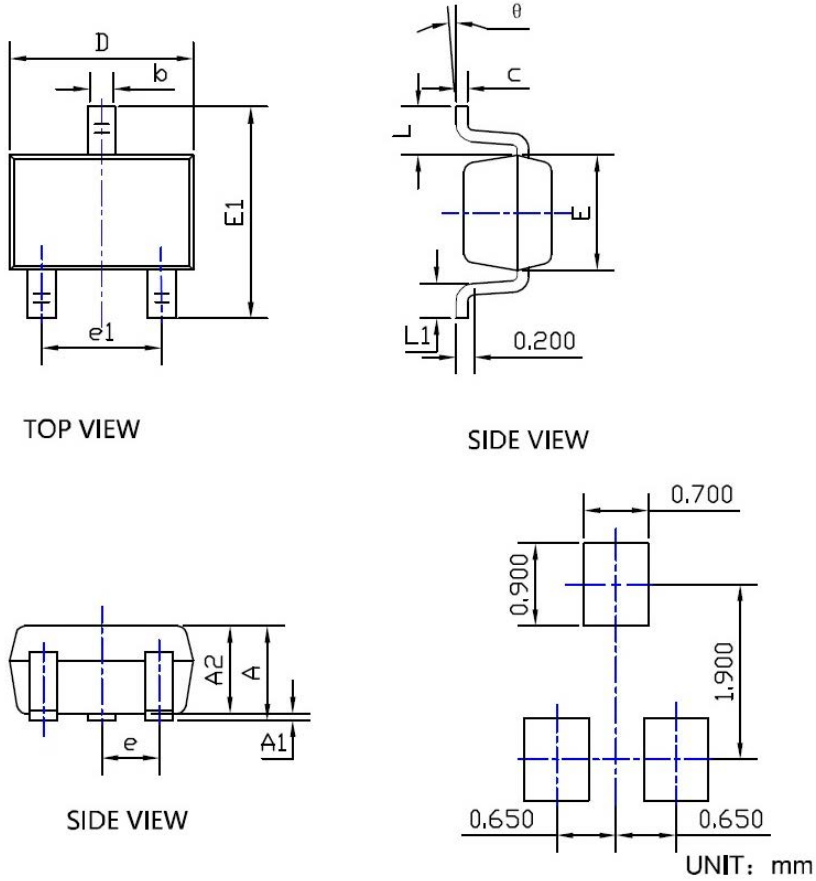


Figure 9. Normalized Thermal Transient Impedance Curve

N-Channel Enhancement Mode MOSFET
SOT323 Package Outline Dimensions


Symbol	Dimensions (unit:mm)			Symbol	Dimensions (unit:mm)		
	Min	Typ	Max		Min	Typ	Max
A	0.90	1.00	1.10	E₁	2.15	2.30	2.45
A₁	--	--	0.10	e	--	0.65	--
A₂	0.90	0.95	1.00	e₁	1.20	1.30	1.40
b	0.15	0.30	0.40	L	--	0.525	--
c	0.10	0.17	0.25	L₁	0.26	0.36	0.46
D	1.80	2.00	2.20	θ	0°		8°
E	1.15	1.25	1.35				